



60V DUAL P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

| V _{(BR)DSS} | R _{DS(on) max} | I _D T _C = +25°C |
|----------------------|--------------------------------|--|
| -60V | $55m\Omega$ @ $V_{GS} = -10V$ | -11.3A |
| | 70mΩ @ V _{GS} = -4.5V | -9.1A |

Description

This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

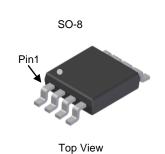
- DC-DC Converters
- Power Management Functions
- Backlighting

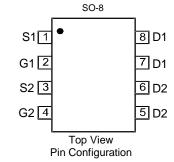
Features

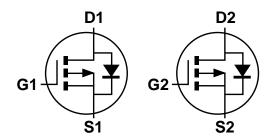
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe Solderable per MIL-STD-202, Method 208³
- Weight: 0.076 grams (Approximate)







Equivalent Circuit

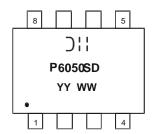
Ordering Information (Note 4)

| Part Number | Case | Packaging |
|---------------|------|--------------------|
| DMP6050SSD-13 | SO-8 | 2500 / Tape & Reel |

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http"//www.diodes.com/products/packages.html.

Marking Information



⊃¦¦ = Manufacturer's Marking
P6050SD = Product Type Marking Code
YYWW = Date Code Marking
YY or YY = Year (ex: 14 = 2014)
WW = Week (01 - 53)



| Characteristic | Symbol | Value | Unit | |
|--|--|------------------|---------------|----|
| Drain-Source Voltage | V_{DSS} | -60 | V | |
| Gate-Source Voltage | | V _{GSS} | ±20 | V |
| Continuous Pusin Courset (Note C) // 40/ | $T_{C} = +25^{\circ}C$ $T_{C} = +70^{\circ}C$ | I _D | -11.3 -9.1 | А |
| Continuous Drain Current (Note 6) V _{GS} = -10V | $T_A = +25$ °C $T_A = +70$ °C | I _D | -4.8 -3.9 | А |
| Pulsed Drain Current (10µs pulse, duty cycle = 1%) | | I _{DM} | -32 | Α |
| Maximum Continuous Body Diode Forward Current (Note 6) | | Is | -2.8 | Α |
| Avalanche Current (Note 7) L = 0.1mH | | I _{AS} | -24.8 | Α |
| Avalanche Energy (Note 7) L = 0.1mH | | Eas | 30.8 | mJ |

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

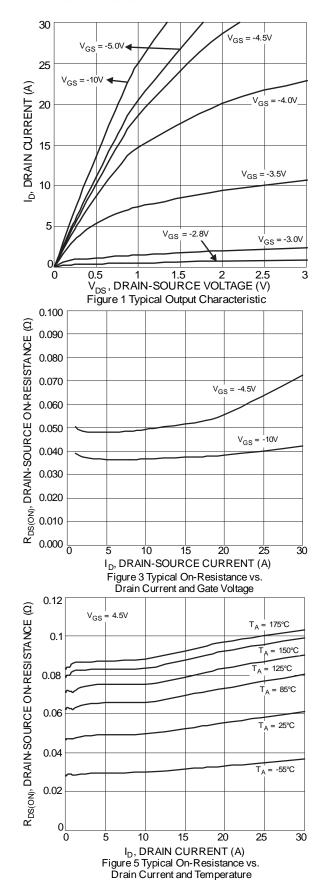
| Characteristic | Symbol | Value | Units | |
|--|------------------------|-----------------------------------|-------------|------|
| Total Power Dissipation (Note 5) | T _A = +25°C | Pn | 1.2 | W |
| Total Power Dissipation (Note 5) | $T_A = +70^{\circ}C$ | PD | 0.9 | |
| Thermal Resistance, Junction to Ambient (Note 5) | Steady state | р | 104 | °C/W |
| Themal Resistance, Junction to Ambient (Note 3) | t<10s | $R_{	heta JA}$ | 45 | |
| Total Power Dissipation (Note 6) | $T_A = +25$ °C | C | 1.7 | W |
| Total Fower Dissipation (Note 6) | $T_A = +70^{\circ}C$ | P_{D} | 1.1 | |
| Thermal Resistance, Junction to Ambient (Note 6) | Steady state | D | 72 | °C/W |
| Thermal Resistance, Junction to Ambient (Note 6) | t<10s | $R_{	heta JA}$ | 37 | |
| Thermal Resistance, Junction to Case (Note 6) | | $R_{\theta JC}$ | 13 | |
| Operating and Storage Temperature Range | | T _J , T _{STG} | -55 to +150 | °C |

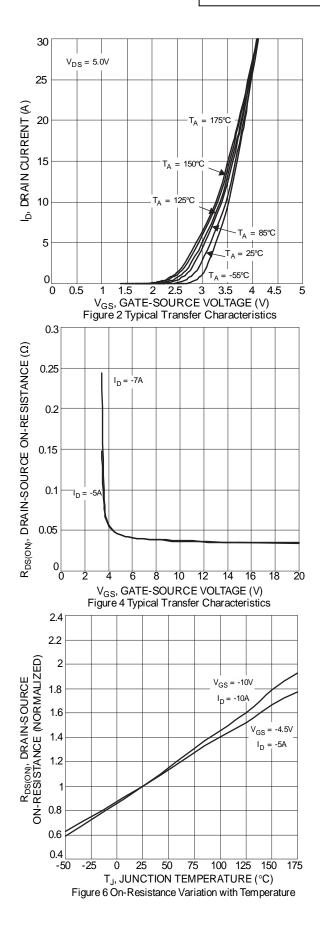
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition | |
|--|----------------------|------|------|------|-------|---|--|
| OFF CHARACTERISTICS (Note 8) | | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | -60 | _ | _ | V | $V_{GS} = 0V, I_D = -250\mu A$ | |
| Zero Gate Voltage Drain Current T _J = +25°C | I _{DSS} | _ | _ | -1 | μΑ | $V_{DS} = -60V, V_{GS} = 0V$ | |
| Gate-Source Leakage | I _{GSS} | _ | _ | ±100 | nA | $V_{GS} = \pm 20V, V_{DS} = 0V$ | |
| ON CHARACTERISTICS (Note 8) | | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | -1.0 | _ | -3.0 | V | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | |
| Static Drain-Source On-Resistance | | - | 36 | 55 | mΩ | $V_{GS} = -10V, I_D = -5A$ | |
| Static Drain-Source On-Resistance | R _{DS (ON)} | - | 47 | 70 | 11177 | $V_{GS} = -4.5V, I_D = -4A$ | |
| Diode Forward Voltage | V _{SD} | - | -0.7 | -1.2 | V | $V_{GS} = 0V, I_{S} = -1A$ | |
| DYNAMIC CHARACTERISTICS (Note 9) | | | | | | | |
| Input Capacitance | C _{iss} | - | 1293 | - | pF |), oo, , , o, , | |
| Output Capacitance | Coss | - | 86.3 | - | pF | $V_{DS} = -30V, V_{GS} = 0V,$ of = 1.0MHz | |
| Reverse Transfer Capacitance | C _{rss} | - | 64.7 | - | pF | 1 = 1.0WHZ | |
| Gate Resistance | R_g | - | 12 | - | Ω | $V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$ | |
| Total Gate Charge (V _{GS} = -4.5V) | Q_{g} | - | 11.9 | - | nC | | |
| Total Gate Charge (V _{GS} = -10V) | Qg | - | 24 | - | nC | V _{DS} = -30V. I _D = -5A | |
| Gate-Source Charge | Q _{gs} | - | 3.6 | - | nC | VDS = -30V, ID = -5A | |
| Gate-Drain Charge | Q_{gd} | - | 5.7 | - | nC | | |
| Turn-On Delay Time | t _{D(on)} | - | 4.3 | - | ns | $V_{GS} = -10V, V_{DS} = -30V,$ $R_{G} = 3\Omega, I_{D} = -5A$ | |
| Turn-On Rise Time | t _r | - | 6.3 | - | ns | | |
| Turn-Off Delay Time | t _{D(off)} | - | 46.7 | - | ns | | |
| Turn-Off Fall Time | t _f | - | 25.3 | - | ns | | |
| Body Diode Reverse Recovery Time | t _{rr} | _ | 13.6 | _ | ns | I _F = -5A, di/dt = 100A/μs | |
| Body Diode Reverse Recovery Charge | Q _{rr} | _ | 7.4 | _ | nC | I _F = -5A, di/dt = 100A/μs | |

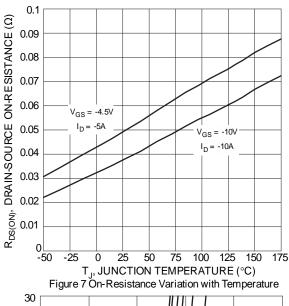
5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.
7. I_{AS} and E_{AS} rating are based on low frequency and duty cycles to keep T_J = +25°C.
8. Short duration pulse test used to minimize self-heating effect.
9. Guaranteed by design. Not subject to product testing.

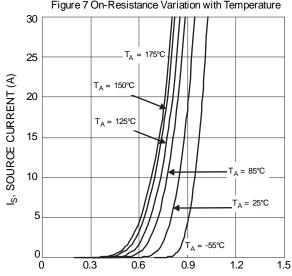


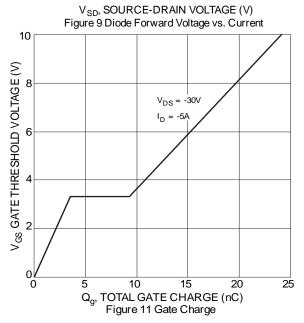












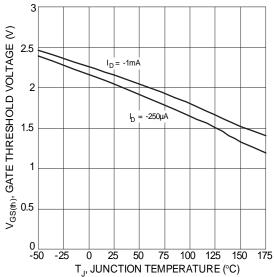
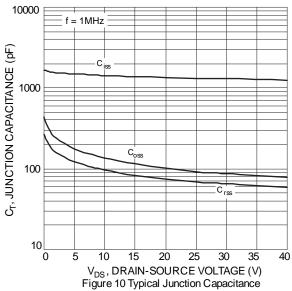
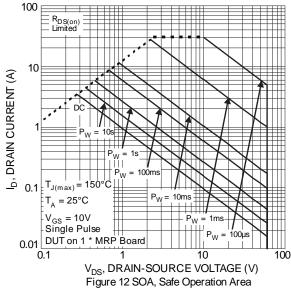
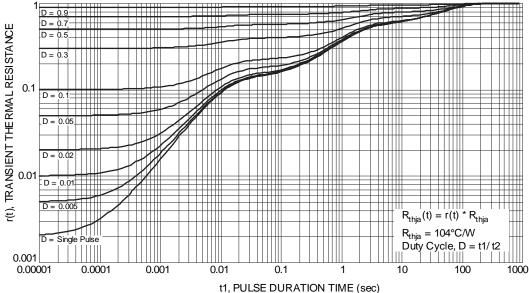


Figure 8 Gate Threshold Variation vs. Ambient Temperature





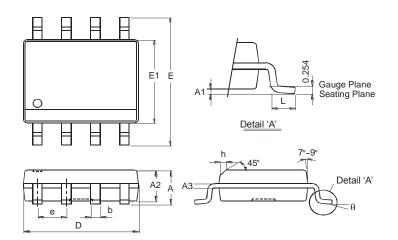




t1, PULSE DURATION TIME (sec) Figure 13 Transient Thermal Resistance

Package Outline Dimensions

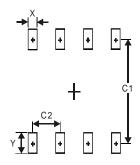
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



| SO-8 | | | | |
|----------------------|----------|------|--|--|
| Dim | Min | Max | | |
| Α | - | 1.75 | | |
| A1 | 0.10 | 0.20 | | |
| A2 | 1.30 | 1.50 | | |
| A3 | 0.15 | 0.25 | | |
| b | 0.3 | 0.5 | | |
| D | 4.85 | 4.95 | | |
| Е | 5.90 | 6.10 | | |
| E1 | 3.85 | 3.95 | | |
| е | 1.27 Typ | | | |
| h | - | 0.35 | | |
| ١ | 0.62 | 0.82 | | |
| θ | 0° | 8° | | |
| All Dimensions in mm | | | | |

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



| Dimensions | Value (in mm) |
|------------|---------------|
| Х | 0.60 |
| Υ | 1.55 |
| C1 | 5.4 |
| C2 | 1.27 |



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